

Ilia Valov

List of Publications by Year in Descending Order

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The third column is the impact factor (IF) of the journal, and the fourth column is the number of citations of the article.

123
papers

6,900
citations

41
h-index

81
g-index

134
ext. papers

7,863
ext. citations

8.2
avg, IF

6.29
L-index

| # | Paper | IF | Citations |
|-----|--|------|-----------|
| 123 | Memristive devices based on single ZnO nanowires from material synthesis to neuromorphic functionalities. <i>Semiconductor Science and Technology</i> , 2022 , 37, 034002 | 1.8 | 0 |
| 122 | Quantum conductance in memristive devices: fundamentals, developments, and applications.. <i>Advanced Materials</i> , 2022 , e2201248 | 24 | 4 |
| 121 | Impact of Zr top electrode on tantalum oxide-based electrochemical metallization resistive switching memory: towards synaptic functionalities.. <i>RSC Advances</i> , 2022 , 12, 14235-14245 | 3.7 | 1 |
| 120 | Standards for the Characterization of Endurance in Resistive Switching Devices. <i>ACS Nano</i> , 2021 , | 16.7 | 36 |
| 119 | Design of Materials Configuration for Optimizing Redox-Based Resistive Switching Memories. <i>Advanced Materials</i> , 2021 , e2105022 | 24 | 5 |
| 118 | Structure-Dependent Influence of Moisture on Resistive Switching Behavior of ZnO Thin Films. <i>Advanced Materials Interfaces</i> , 2021 , 8, 2100915 | 4.6 | 4 |
| 117 | Impact of moisture absorption on the resistive switching characteristics of a polyethylene oxide-based atomic switch. <i>Journal of Materials Chemistry C</i> , 2021 , 9, 11198-11206 | 7.1 | 2 |
| 116 | Design of defect-chemical properties and device performance in memristive systems. <i>Science Advances</i> , 2020 , 6, eaaz9079 | 14.3 | 31 |
| 115 | Brain-Inspired Structural Plasticity through Reweighting and Rewiring in Multi-Terminal Self-Organizing Memristive Nanowire Networks. <i>Advanced Intelligent Systems</i> , 2020 , 2, 2000096 | 6 | 27 |
| 114 | Memristors with alloyed electrodes. <i>Nature Nanotechnology</i> , 2020 , 15, 510-511 | 28.7 | 5 |
| 113 | Copper facilitated nickel oxy-hydroxide films as efficient synergistic oxygen evolution electrocatalyst. <i>Journal of Catalysis</i> , 2020 , 384, 189-198 | 7.3 | 0 |
| 112 | Nanoscale Electrochemical Studies: How Can We Use the Atomic Switch. <i>Advances in Atom and Single Molecule Machines</i> , 2020 , 73-93 | 0 | |
| 111 | Water-Mediated Ionic Migration in Memristive Nanowires with a Tunable Resistive Switching Mechanism. <i>ACS Applied Materials & Interfaces</i> , 2020 , 12, 48773-48780 | 9.5 | 13 |
| 110 | Brain-Inspired Structural Plasticity through Reweighting and Rewiring in Multi-Terminal Self-Organizing Memristive Nanowire Networks. <i>Advanced Intelligent Systems</i> , 2020 , 2, 2080071 | 6 | 2 |
| 109 | Synaptic and neuromorphic functions: general discussion. <i>Faraday Discussions</i> , 2019 , 213, 553-578 | 3.6 | 1 |
| 108 | Electrochemical metallization ReRAMs (ECM) - Experiments and modelling: general discussion. <i>Faraday Discussions</i> , 2019 , 213, 115-150 | 3.6 | 4 |
| 107 | Phase-change memories (PCM) - Experiments and modelling: general discussion. <i>Faraday Discussions</i> , 2019 , 213, 393-420 | 3.6 | 3 |

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| 106 | Active Electrode Redox Reactions and Device Behavior in ECM Type Resistive Switching Memories. <i>Advanced Electronic Materials</i> , 2019 , 5, 1800933 | 6.4 | 40 |
| 105 | Recent Developments and Perspectives for Memristive Devices Based on Metal Oxide Nanowires. <i>Advanced Electronic Materials</i> , 2019 , 5, 1800909 | 6.4 | 58 |
| 104 | Electrolysis of Water at Atomically Tailored Epitaxial Cobaltite Surfaces. <i>Chemistry of Materials</i> , 2019 , 31, 2337-2346 | 9.6 | 14 |
| 103 | Resistivity control by the electrochemical removal of dopant atoms from a nanodot. <i>Faraday Discussions</i> , 2019 , 213, 29-40 | 3.6 | 6 |
| 102 | Electrochemically prepared oxides for resistive switching memories. <i>Faraday Discussions</i> , 2019 , 213, 165-181 | 3.8 | 22 |
| 101 | Ionic Modulation of Electrical Conductivity of ZnO Due to Ambient Moisture. <i>Advanced Materials Interfaces</i> , 2019 , 6, 1900803 | 4.6 | 16 |
| 100 | Recommended Methods to Study Resistive Switching Devices. <i>Advanced Electronic Materials</i> , 2019 , 5, 1800143 | 6.4 | 297 |
| 99 | Electrochemically prepared oxides for resistive switching devices. <i>Electrochimica Acta</i> , 2018 , 274, 103-116 | 1.7 | 17 |
| 98 | Nanoarchitectonics for Controlling the Number of Dopant Atoms in Solid Electrolyte Nanodots. <i>Advanced Materials</i> , 2018 , 30, 1703261 | 24 | 37 |
| 97 | Degradation Kinetics during Oxygen Electrocatalysis on Perovskite-Based Surfaces in Alkaline Media. <i>Langmuir</i> , 2018 , 34, 1347-1352 | 4 | 15 |
| 96 | Effects of moisture and redox reactions in VCM and ECM resistive switching memories. <i>Journal Physics D: Applied Physics</i> , 2018 , 51, 413001 | 3 | 72 |
| 95 | Oxygen Exchange Processes between Oxide Memristive Devices and Water Molecules. <i>Advanced Materials</i> , 2018 , 30, e1800957 | 24 | 41 |
| 94 | Processes and Effects of Oxygen and Moisture in Resistively Switching TaOx and HfOx. <i>Advanced Electronic Materials</i> , 2018 , 4, 1700458 | 6.4 | 65 |
| 93 | Self-limited single nanowire systems combining all-in-one memristive and neuromorphic functionalities. <i>Nature Communications</i> , 2018 , 9, 5151 | 17.4 | 83 |
| 92 | Oxide Thin Films for Memristive Devices 2018 , 346-356 | | |
| 91 | Spring-Like Pseudoelectroelasticity of Monocrystalline CuS Nanowire. <i>Nano Letters</i> , 2018 , 18, 5070-5077 | 11.5 | 9 |
| 90 | Silicon Oxide (SiO ₂): A Promising Material for Resistance Switching?. <i>Advanced Materials</i> , 2018 , 30, e1801187 | 1.7 | 105 |
| 89 | Coexistence of Grain-Boundaries-Assisted Bipolar and Threshold Resistive Switching in Multilayer Hexagonal Boron Nitride. <i>Advanced Functional Materials</i> , 2017 , 27, 1604811 | 15.6 | 149 |

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| 88 | Direct Probing of the Dielectric Scavenging-Layer Interface in Oxide Filamentary-Based Valence Change Memory. <i>ACS Applied Materials & Interfaces</i> , 2017 , 9, 10820-10824 | 9.5 | 39 |
| 87 | SET kinetics of electrochemical metallization cells: influence of counter-electrodes in SiO/Ag based systems. <i>Nanotechnology</i> , 2017 , 28, 135205 | 3.4 | 37 |
| 86 | Interfacial Metal-Oxide Interactions in Resistive Switching Memories. <i>ACS Applied Materials & Interfaces</i> , 2017 , 9, 19287-19295 | 9.5 | 74 |
| 85 | Electrochemical Tantalum Oxide for Resistive Switching Memories. <i>Advanced Materials</i> , 2017 , 29, 1703354 | 5.4 | 52 |
| 84 | Non-volatile memories: Organic memristors come of age. <i>Nature Materials</i> , 2017 , 16, 1170-1172 | 27 | 30 |
| 83 | Interfacial interactions and their impact on redox-based resistive switching memories (ReRAMs). <i>Semiconductor Science and Technology</i> , 2017 , 32, 093006 | 1.8 | 72 |
| 82 | Ordering and Phase Control in Epitaxial Double-Perovskite Catalysts for the Oxygen Evolution Reaction. <i>ACS Catalysis</i> , 2017 , 7, 7029-7037 | 13.1 | 30 |
| 81 | Multibit memory operation of metal-oxide bi-layer memristors. <i>Scientific Reports</i> , 2017 , 7, 17532 | 4.9 | 133 |
| 80 | Editorial for the JECR special issue on resistive switching: Oxide materials, mechanisms, and devices. <i>Journal of Electroceramics</i> , 2017 , 39, 1-3 | 1.5 | 4 |
| 79 | Electrochemical Metallization Memories 2016 , 483-514 | | 14 |
| 78 | Physics and Chemistry of Nanoionic Cells 2016 , 253-288 | | 4 |
| 77 | Humidity effects on the redox reactions and ionic transport in a Cu/Ta ₂ O ₅ /Pt atomic switch structure. <i>Japanese Journal of Applied Physics</i> , 2016 , 55, 06GJ09 | 1.4 | 41 |
| 76 | PrxBa _{1-x} CoO ₃ Oxide Electrodes for Oxygen Evolution Reaction in Alkaline Solutions by Chemical Solution Deposition. <i>Journal of the Electrochemical Society</i> , 2016 , 163, F166-F170 | 3.9 | 16 |
| 75 | Resistive Switching Mechanisms on TaO _x and SrRuO ₃ Thin-Film Surfaces Probed by Scanning Tunneling Microscopy. <i>ACS Nano</i> , 2016 , 10, 1481-92 | 16.7 | 79 |
| 74 | Nanoscale cation motion in TaO(x), HfO(x) and TiO(x) memristive systems. <i>Nature Nanotechnology</i> , 2016 , 11, 67-74 | 28.7 | 419 |
| 73 | Electrochemical processes and device improvement in conductive bridge RAM cells. <i>Physica Status Solidi (A) Applications and Materials Science</i> , 2016 , 213, 274-288 | 1.6 | 44 |
| 72 | Nanoscale electrochemistry using dielectric thin films as solid electrolytes. <i>Nanoscale</i> , 2016 , 8, 13828-37 | 7.7 | 102 |
| 71 | (Invited) Mobile Ions, Transport and Redox Processes in Memristive Devices. <i>ECS Transactions</i> , 2016 , 75, 27-39 | 1 | 11 |

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|----|--|------|-----|
| 70 | Stability and Degradation of Perovskite Electrocatalysts for Oxygen Evolution Reaction. <i>Electrochimica Acta</i> , 2016 , 218, 156-162 | 6.7 | 26 |
| 69 | Ionic conductivity of low yttria-doped cubic zirconium oxide nitride single crystals. <i>Solid State Ionics</i> , 2016 , 296, 42-46 | 3.3 | 6 |
| 68 | Understanding the conductive channel evolution in Na:WO(3-x)-based planar devices. <i>Nanoscale</i> , 2015 , 7, 6023-30 | 7.7 | 13 |
| 67 | Influence of Graphene Interlayers on Electrode-Electrolyte Interfaces in Resistive Random Accesses Memory Cells. <i>Materials Research Society Symposia Proceedings</i> , 2015 , 1729, 29-34 | | 4 |
| 66 | Processes and Limitations during Filament Formation and Dissolution in GeSx-based ReRAM Memory Cells. <i>Journal of Physical Chemistry C</i> , 2015 , 119, 18678-18685 | 3.8 | 18 |
| 65 | Redox Reactions at Cu,Ag/Ta2O5 Interfaces and the Effects of Ta2O5 Film Density on the Forming Process in Atomic Switch Structures. <i>Advanced Functional Materials</i> , 2015 , 25, 6374-6381 | 15.6 | 133 |
| 64 | Graphene-Modified Interface Controls Transition from VCM to ECM Switching Modes in Ta/TaOx Based Memristive Devices. <i>Advanced Materials</i> , 2015 , 27, 6202-7 | 24 | 120 |
| 63 | Modeling of Quantized Conductance Effects in Electrochemical Metallization Cells. <i>IEEE Nanotechnology Magazine</i> , 2015 , 14, 505-512 | 2.6 | 30 |
| 62 | Volatile resistance states in electrochemical metallization cells enabling non-destructive readout of complementary resistive switches. <i>Nanotechnology</i> , 2014 , 25, 425202 | 3.4 | 55 |
| 61 | Live demonstration: An associative capacitive network based on nanoscale complementary resistive switches 2014 , | | 1 |
| 60 | Physical origins and suppression of Ag dissolution in GeS(x)-based ECM cells. <i>Physical Chemistry Chemical Physics</i> , 2014 , 16, 18217-25 | 3.6 | 25 |
| 59 | Electrochemical dynamics of nanoscale metallic inclusions in dielectrics. <i>Nature Communications</i> , 2014 , 5, 4232 | 17.4 | 411 |
| 58 | Nanobattery Effect in RRAMs Implications on Device Stability and Endurance. <i>IEEE Electron Device Letters</i> , 2014 , 35, 208-210 | 4.4 | 51 |
| 57 | (Keynote) Atomic Scale and Interface Interactions in Redox-Based Resistive Switching Memories. <i>ECS Transactions</i> , 2014 , 64, 3-18 | 1 | 8 |
| 56 | Quantum size effects and non-equilibrium states in nanoscale silicon dioxide based resistive switches 2014 , | | 2 |
| 55 | Statistical modeling of electrochemical metallization memory cells 2014 , | | 4 |
| 54 | Redox-Based Resistive Switching Memories (ReRAMs): Electrochemical Systems at the Atomic Scale. <i>ChemElectroChem</i> , 2014 , 1, 26-36 | 4.3 | 119 |
| 53 | Impact of the Counter-Electrode Material on Redox Processes in Resistive Switching Memories. <i>ChemElectroChem</i> , 2014 , 1, 1287-1292 | 4.3 | 68 |

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| 52 | Generic relevance of counter charges for cation-based nanoscale resistive switching memories. <i>ACS Nano</i> , 2013 , 7, 6396-402 | 16.7 | 183 |
| 51 | Chemically-inactive interfaces in thin film Ag/AgI systems for resistive switching memories. <i>Scientific Reports</i> , 2013 , 3, 1169 | 4.9 | 18 |
| 50 | Switching kinetics of electrochemical metallization memory cells. <i>Physical Chemistry Chemical Physics</i> , 2013 , 15, 6945-52 | 3.6 | 126 |
| 49 | New insights into redox based resistive switches 2013 , | | 3 |
| 48 | Bond nature of active metal ions in SiO ₂ -based electrochemical metallization memory cells. <i>Nanoscale</i> , 2013 , 5, 1781-4 | 7.7 | 41 |
| 47 | Nucleation and growth phenomena in nanosized electrochemical systems for resistive switching memories. <i>Journal of Solid State Electrochemistry</i> , 2013 , 17, 365-371 | 2.6 | 75 |
| 46 | Preparation and characterization of GeS _x thin-films for resistive switching memories. <i>Thin Solid Films</i> , 2013 , 527, 299-302 | 2.2 | 20 |
| 45 | Nanobatteries in redox-based resistive switches require extension of memristor theory. <i>Nature Communications</i> , 2013 , 4, 1771 | 17.4 | 395 |
| 44 | Cation-based resistance change memory. <i>Journal Physics D: Applied Physics</i> , 2013 , 46, 074005 | 3 | 147 |
| 43 | Comment on Dynamic Processes of Resistive Switching in Metallic Filament-Based Organic Memory Devices <i>Journal of Physical Chemistry C</i> , 2013 , 117, 11878-11880 | 3.8 | 10 |
| 42 | An associative capacitive network based on nanoscale complementary resistive switches for memory-intensive computing. <i>Nanoscale</i> , 2013 , 5, 5119-28 | 7.7 | 39 |
| 41 | (Invited) The Role of Electrochemical Interfaces in ReRAM Memory Cells. <i>ECS Transactions</i> , 2013 , 58, 189-196 | 1 | 2 |
| 40 | Comment on real-time observation on dynamic growth/dissolution of conductive filaments in oxide-electrolyte- based ReRAM. <i>Advanced Materials</i> , 2013 , 25, 162-4 | 24 | 30 |
| 39 | Simulation of polarity independent RESET in electrochemical metallization memory cells 2013 , | | 9 |
| 38 | Ag/GeS _x /Pt-based complementary resistive switches for hybrid CMOS/nanoelectronic logic and memory architectures. <i>Scientific Reports</i> , 2013 , 3, 2856 | 4.9 | 40 |
| 37 | Rate-limiting processes in the fast SET operation of a gapless-type Cu-Ta ₂ O ₅ atomic switch. <i>AIP Advances</i> , 2013 , 3, 032114 | 1.5 | 37 |
| 36 | Effects of Moisture on the Switching Characteristics of Oxide-Based, Gapless-Type Atomic Switches. <i>Advanced Functional Materials</i> , 2012 , 22, 70-77 | 15.6 | 217 |
| 35 | Quantum conductance and switching kinetics of AgI-based microcrossbar cells. <i>Nanotechnology</i> , 2012 , 23, 145703 | 3.4 | 118 |

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| 34 | Nanoionic transport and electrochemical reactions in resistively switching silicon dioxide. <i>Nanoscale</i> , 2012 , 4, 3040-3 | 7.7 | 93 |
| 33 | Atomically controlled electrochemical nucleation at superionic solid electrolyte surfaces. <i>Nature Materials</i> , 2012 , 11, 530-5 | 27 | 187 |
| 32 | Direct observation of charge transfer in solid electrolyte for electrochemical metallization memory. <i>Advanced Materials</i> , 2012 , 24, 4552-6 | 24 | 39 |
| 31 | Redox processes in silicon dioxide thin films using copper microelectrodes. <i>Applied Physics Letters</i> , 2011 , 99, 203103 | 3.4 | 61 |
| 30 | Capacity based nondestructive readout for complementary resistive switches. <i>Nanotechnology</i> , 2011 , 22, 395203 | 3.4 | 39 |
| 29 | Electrochemical metallization memories--fundamentals, applications, prospects. <i>Nanotechnology</i> , 2011 , 22, 254003 | 3.4 | 565 |
| 28 | Electrochemical metallization memories--fundamentals, applications, prospects. <i>Nanotechnology</i> , 2011 , 22, 289502 | 3.4 | 193 |
| 27 | Electrochemical activation of molecular nitrogen at the Ir/YSZ interface. <i>Physical Chemistry Chemical Physics</i> , 2011 , 13, 3394-410 | 3.6 | 17 |
| 26 | An EMF cell with a nitrogen solid electrolyte--on the transference of nitrogen ions in yttria-stabilized zirconia. <i>Physical Chemistry Chemical Physics</i> , 2011 , 13, 1239-42 | 3.6 | 8 |
| 25 | Proton mobility in SiO ₂ thin films and impact of hydrogen and humidity on the resistive switching effect. <i>Materials Research Society Symposia Proceedings</i> , 2011 , 1330, 30201 | | 24 |
| 24 | A Study of the Kinetics of the Electrochemical Deposition of Ce ³⁺ /Ce ⁴⁺ Oxides. <i>NATO Science for Peace and Security Series B: Physics and Biophysics</i> , 2011 , 167-172 | 0.2 | 2 |
| 23 | Electrochemical Reactions in Nanoionics - Towards Future Resistive Switching Memories. <i>ECS Transactions</i> , 2009 , 25, 431-437 | 1 | 7 |
| 22 | Ionic and electronic conductivity of nitrogen-doped YSZ single crystals. <i>Solid State Ionics</i> , 2009 , 180, 1463-1470 | 3.3 | 28 |
| 21 | Oxide nitrides: From oxides to solids with mobile nitrogen ions. <i>Progress in Solid State Chemistry</i> , 2009 , 37, 81-131 | 8 | 58 |
| 20 | Thermodynamics, structure and kinetics in the system Ga ₂ O ₃ . <i>Progress in Solid State Chemistry</i> , 2009 , 37, 132-152 | 8 | 30 |
| 19 | Defect chemistry of the cage compound, Ca ₁₂ Al ₁₄ O _(33-δ) --understanding the route from a solid electrolyte to a semiconductor and electricle. <i>Physical Chemistry Chemical Physics</i> , 2009 , 11, 3105-14 | 3.6 | 49 |
| 18 | Faradaic currents during electroforming of resistively switching Ag-Ge-Se type electrochemical metallization memory cells. <i>Physical Chemistry Chemical Physics</i> , 2009 , 11, 5974-9 | 3.6 | 43 |
| 17 | A chemically driven insulator-metal transition in non-stoichiometric and amorphous gallium oxide. <i>Nature Materials</i> , 2008 , 7, 391-8 | 27 | 136 |

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|----|---|-----|----|
| 16 | Electrocatalysts for bifunctional oxygen/air electrodes. <i>Journal of Power Sources</i> , 2008 , 185, 727-733 | 8.9 | 78 |
| 15 | Defect Chemistry and Transport Properties of Nitrogen-Doped YSZ. <i>Zeitschrift Fur Anorganische Und Allgemeine Chemie</i> , 2008 , 634, 2011-2011 | 1.3 | |
| 14 | Electrode activation and degradation: Morphology changes of platinum electrodes on YSZ during electrochemical polarisation. <i>Solid State Ionics</i> , 2008 , 179, 1835-1848 | 3.3 | 36 |
| 13 | Electrocatalysts and Electrode Design for Bifunctional Oxygen/Air Electrodes. <i>NATO Science for Peace and Security Series B: Physics and Biophysics</i> , 2008 , 305-310 | 0.2 | 1 |
| 12 | Preparation of nitrogen-doped YSZ thin films by pulsed laser deposition and their characterization. <i>Journal of Materials Science</i> , 2007 , 42, 1931-1941 | 4.3 | 17 |
| 11 | Kinetic studies of the electrochemical nitrogen reduction and incorporation into yttria stabilized zirconia. <i>Solid State Ionics</i> , 2006 , 177, 1619-1624 | 3.3 | 11 |
| 10 | Electrochemical Incorporation of Nitrogen into a Zirconia Solid Electrolyte. <i>Electrochemical and Solid-State Letters</i> , 2006 , 9, F23 | | 12 |
| 9 | Nitrogen Tracer Diffusion in Yttria Doped Zirconium Oxonitride. <i>Defect and Diffusion Forum</i> , 2005 , 237-240, 479-484 | 0.7 | 11 |
| 8 | Electrochemical growth of thin La ₂ O ₃ films on oxide and metal surfaces. <i>Materials Science and Engineering C</i> , 2003 , 23, 123-128 | 8.3 | 34 |
| 7 | Chemical composition and corrosion resistance of passive chromate films formed on stainless steels 316 L and 1.4301. <i>Materials Chemistry and Physics</i> , 2002 , 73, 252-258 | 4.4 | 26 |
| 6 | Study of the kinetics of processes during electrochemical deposition of zirconia from nonaqueous electrolytes. <i>Electrochimica Acta</i> , 2002 , 47, 4419-4431 | 6.7 | 23 |
| 5 | Electrochemical deposition of thin zirconia films on stainless steel 316 L. <i>Materials Chemistry and Physics</i> , 2000 , 65, 222-225 | 4.4 | 47 |
| 4 | 2022 roadmap on neuromorphic computing and engineering. <i>Neuromorphic Computing and Engineering</i> , | | 24 |
| 3 | Poster: Memristive Systems 523-587 | | |
| 2 | Nanosession: Electrochemical Metallization Memories 207-217 | | |
| 1 | Forming-Free Resistive Switching of Electrochemical Titanium Oxide Localized Nanostructures: Anodization, Chemical Composition, Nanoscale Size Effects, and Memristive Storage. <i>Advanced Electronic Materials</i> , 2002 , 15 | 6.4 | 0 |